MMIC

Directional Coupler Die

EDC21-24-D+

 50Ω 21 dB 4 to 20 GHz

The Big Deal

- Wideband, 4-20 GHz
- Excellent coupling flatness 21±2 dB typ.
- Highly repeatable performance (GaAs based design)



Product Overview

Mini-Circuits' EDC21-24-D+ is a MMIC wideband 21 dB directional coupler die that operates from 4 to 20 GHz. It provides excellent coupling flatness over a broad bandwidth and good return loss. This coupler also provides a quadrature phase shift between the signal at the through port and coupler port. Manufacturing using GaAs Technology, this model results in relatively high repeatablility in performance.

Key Features

Feature	Advantages
Wideband, 4-20 GHz	EDC21-24-D+ can be used in many applications, saving component count. Also ideal for wideband applications such as military and instrumentation.
Excellent coupling flatness	Excellent coupling flatness minimizes need for external compensation to achieve flatness
Unpackaged Die	Enables user to integrate it directly into hybrids.

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Product Features

- Low mainline loss, 0.7 dB typ.
- Excellent coupling flatness, ±2dB
- Highly repeatable performance (GaAs based design)
- No external termination required

Typical Applications

- Satellite communications
- Wireless infrastructure
- Test and measurements



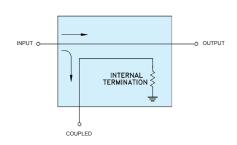
+RoHS Compliant
The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

Ordering Information: Refer to Last Page

General Description

Mini-Circuits' EDC21-24-D+ is a MMIC wideband 21 dB directional coupler die that operates from 4 to 20 GHz. It provides excellent coupling flatness over a broad bandwidth and good return loss. This coupler also provides a quadrature phase shift between the signal at the through port and coupler port. Manufacturing using GaAs Technology, this model results in relatively high repeatability in performance.

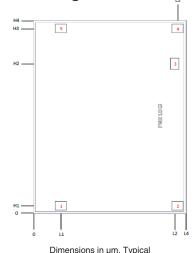
Simplified Schematic and Pad Description



Pad#	Function
1	INPUT
2	COUPLED
3	TERMINATION
4	ISOLATED1
5	OUTPUT

Note: 1. Connect to pad 3, see assembly diagram (page 4)

Bonding Pad Position



	Zimenelene in pin, Typica.											
	L1	L2	L3	L4	H1	H2	НЗ	H4	Thickness	Die Size	Bond Pad #1,#2,#4, & #5 Size	Bond Pad #3 Size
	363	1871	1909	2020	105	1980	2446	2550	100	2020 x 2550	142 x 107	107 x 142
٠,		-										

Electrical Specifications¹ at 25°C

Parameter	Frequency (MHz)	Min.	Тур.	Max.	Unit	
Frequency Range		4000		20000	MHz	
	4000 - 8000		0.4			
Mainline Loss	8000 - 10000		0.7		dB	
Mairille Loss	10000 - 15000		0.8		иБ	
	15000 - 20000		0.9			
	4000 - 8000		22			
Naminal Counting	8000 - 10000		21		dB	
Nominal Coupling	10000 - 15000		21		uБ	
	15000 - 20000		21			
Coupling Flatness(±)	4000 - 20000		2.0		dB	
	4000 - 8000		21			
Directivity	8000 - 10000		19		dB	
Directivity	10000 - 15000		16		иь	
	15000 - 20000		14			
	4000 - 8000		26			
Deturn Less (Innut)	8000 - 10000		16		dB	
Return Loss (Input)	10000 - 15000		17		иь	
	15000 - 20000		21			
	4000 - 8000		26			
Deturn Less (Outnut)	8000 - 10000		16		dB	
Return Loss (Output)	10000 - 15000		17		иь	
	15000 - 20000		21			
	4000 - 8000		19			
D-t (O	8000 - 10000		16		-ID	
Return Loss (Coupled)	10000 - 15000		15		dB	
	15000 - 20000		21			

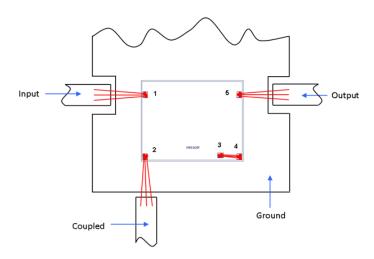
^{1.} Measured on Mini-Circuits Characterization Test Board, TB-978+. Die packaged in 4x4 mm, 24-lead MCLP package.

Maximum Ratings^{1,2}

3				
Parameter	Ratings			
Operating Temperature	-40°C to 85°C			
Input Power	32.5 dBm (5 minute max.) 29.5 dBm (continuous)			
Power at internal termination	15 dBm (5 minute max.) 12 dBm (continuous)			

^{2.} Permanent damage may occur if any of these limits are exceeded.

Assembly Diagram



Assembly and Handling Procedure

- 1. Storage
 - Dice should be stored in a dry nitrogen purged desiccators or equivalent.
- 2. ESD

MMIC dice are susceptible to electrostatic and mechanical damage. Die are supplied in antistatic protected material, which should be opened in clean room conditions at an appropriately grounded anti-static workstation. Devices need careful handling using correctly designed collets, vacuum pickup tips or sharp antistatic tweezers to deter ESD damage to dice.

- 3. Die Attach
 - The Die mounting surface must be clean and flat. Using conductive silver filled epoxy, recommended epoxies are DieMat DM6030HK-PT/H579 or Ablestik 84-1LMISR4. Apply sufficient epoxy to meet required epoxy bond line thickness, epoxy fillet height and epoxy coverage around total Die periphery. Parts shall be cured in a nitrogen filled atmosphere per manufacturer's cure condition. It is recommended to use antistatic Die pick up tools only.
- Wire Bonding

Bond pad openings in the surface passivation above the bond pads are provided to allow wire bonding to the dice gold bond pads. Thermosonic bonding is used with minimized ultrasonic content. Bond force, time, ultrasonic power and temperature are all critical parameters. Suggested wire is pure gold, 1 mil diameter. Bonds must be made from the bond pads on the Die to the package or substrate. All bond wires should be kept as short as low as reasonable to minimize performance degradation due to undesirable series inductance.



Additional Detailed Technic additional information is available on our						
	Data Table					
Performance Data	Swept Graphs	Swept Graphs				
	S-Parameter (S2P Files)	S-Parameter (S2P Files)				
Case Style	Die	Die				
	Quantity, Package	Model No.				
Die Ordering and packaging information (Note 5)	Small, Gel - Pak: 5,10,50, KGD* Medium [†] , Partial wafer: KGD*<300 Large [†] , Full wafer	EDC21-24-DG+ EDC21-24-DP+ EDC21-24-DF+				
mormation (Note 5)	†Available upon request contact sales representative					
Refer to <u>AN-60-067</u>						
Environmental Ratings	ENV-80					

^{*}Known Good Dice ("KGD") means that the dice are taken from PCM good wafer and visually inspected in question have been subjected to Mini-Circuits while this is not definitive, it does help to provide a higher degree of confidence that dice are capable of meeting typical RF electrical parameters specified by Mini-Circuits.

ESD Rating**

Human Body Model (HBM): Class 1B (500V) in accordance with ANSI/ESD STM 5.1 - 2001

Additional Notes

- A. Performance and quality attributes and conditions not expressly stated in this specification document are intended to be excluded and do not form a part of this specification document.
- B. Electrical specifications and performance data contained in this specification document are based on Mini-Circuit's applicable established test performance criteria and measurement instructions.
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^{**} Tested in industry standard 4x4 mm, 24-lead MCLP package.

TEST CONDITIONS: INPUT POWER =0 dBm @Temperature = +25°C

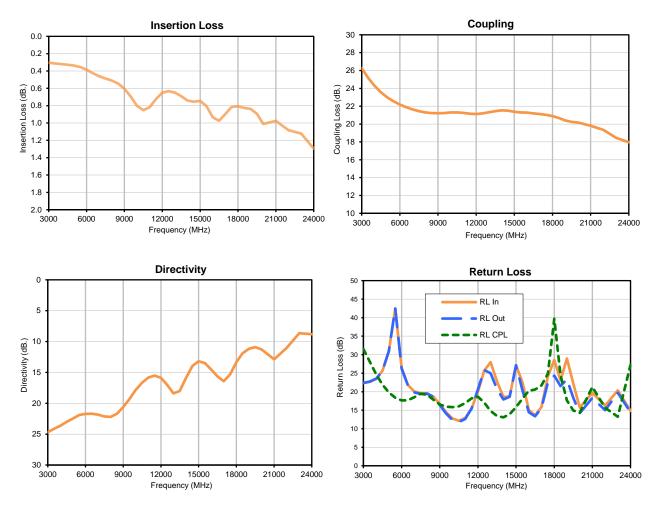
FREQUENCY	INSERTION LOSS	COUPLING	DIRECTIVITY		RETURN LOSS	
(MHz)	(dB)	(dB)	(dB)		(dB)	
, ,	, ,		` ,	IN	OUT	CPL
3000	0.30	26.28	24.68	22.42	22.37	31.53
3500	0.31	25.18	24.12	22.66	22.74	28.11
4000	0.32	24.30	23.62	23.47	23.52	24.68
4500	0.33	23.59	23.01	25.66	25.62	21.93
5000	0.34	23.01	22.47	30.87	31.01	19.80
5500	0.35	22.55	21.91	42.51	42.54	18.40
6000	0.38	22.19	21.70	26.44	26.26	17.66
6500	0.43	21.89	21.70	21.86	21.72	17.68
7000	0.46	21.65	21.86	20.07	19.82	18.53
7500	0.49	21.45	22.12	19.64	19.43	19.48
8000	0.51	21.31	22.20	19.59	19.45	19.17
8500 9000	0.54 0.60	21.23 21.21	21.69 20.61	18.69 16.68	18.59 16.43	17.85 16.57
9500	0.60	21.21	19.31	14.48	14.10	15.98
10000	0.70	21.30	17.82	12.76	12.34	15.83
10500	0.85	21.30	16.65	12.16	11.82	16.06
11000		21.24	15.83	12.89		
	0.82				12.65	16.92
11500	0.72	21.16	15.52	15.44	15.47	18.20
12000	0.65	21.13	15.88	20.09	20.67	18.65
12500	0.63	21.20	17.02	25.70	25.86	17.08
13000	0.65	21.33	18.40	27.99	25.00	14.81
13500	0.69	21.45	18.01	22.80	20.71	13.46
14000	0.74	21.54	15.87	18.61	17.91	13.09
14500	0.76	21.49	13.96	18.73	18.65	13.95
15000	0.74	21.37	13.19	27.10	27.14	15.85
15500	0.80	21.31	13.50	22.52	20.41	18.14
16000	0.94	21.28	14.52	15.05	14.44	20.29
16500	0.97	21.20	15.65	13.66	13.37	20.58
17000	0.90	21.12	16.43	15.89	15.57	21.72
17500	0.81	21.03	15.33	24.14	22.47	24.86
18000	0.81	20.89	13.36	28.56	24.37	39.71
18500	0.83	20.68	11.90	23.11	21.56	24.43
19000	0.84	20.41	11.16	28.96	23.34	17.64
19500	0.89	20.24	10.90	22.17	18.36	14.92
20000	1.01	20.24	11.27	15.77	14.20	14.92
21000	0.98	19.81	12.87	19.67	18.33	21.28
22000	1.08	19.36	11.04	16.26	15.03	15.66
23000	1.12	18.45	8.65	20.39	19.73	13.25
24000	1.29	17.96	8.80	14.83	14.47	27.31

Note: Testdata of Die packaged in 4x4 mm, 24-lead MCLP package





Typical Performance Curves



Note: Testdata of Die packaged in 4x4 mm, 24-lead MCLP package









All Mini-Circuits products are manufactured under exacting quality assurance and control standards, and are capable of meeting published specifications after being subjected to any or all of the following physical and environmental test.

Specification	Test/Inspection Condition	Reference/Spec
Operating Temperature	-40° to 85° C or -40° to 105° C or -55° to 105° C or -45° to 105° C 105° C Ambient Environment	Refer to Individual Model Data Sheet
Storage Environment (Die)	-65° to 150°C	Individual Model Data Sheet
Storage Environment(Packaging)	-40° to 70°C and 40 to 60% humidity (In Factory Shipped Package)	

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